

Wenner, Rebecca

From: Wenner, Rebecca
Sent: Tuesday, March 28, 2017 7:50 AM
To: Fowler, John
Subject: RE: Recent project plan where XRF was used on CRT glass

Categories: EZ Record - Shared

John,

Do you have a few minutes to talk today about how you used the XRF on the glass at Recycletronics?

I am going up next week with Mike Martin (R7 inspector). We are going to do some soil screening using the XRF and we are also going to use the XRF to test the leaded glass. I am curious about what settings you used for the glass, and also I wanted help understanding your results. The glass is reported as a percentage, I am curious if the percentage was a setting on the XRF, or if you calculated it based on the XRF reading, and if so, why?

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From: Fowler, John
Sent: Monday, March 20, 2017 12:06 PM
To: Wenner, Rebecca <wenner.rebecca@epa.gov>
Subject: Recent project plan where XRF was used on CRT glass

Rebecca,

Attached is a project plan where XRF was used on CRT glass. I hope this helps.

John F.

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